Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/029,439	TANAKA ET AL.	
Examiner	Art Unit	
PHUC H. TRAN	2666	

SEARCHED					
Class	Subclass	Date	Examiner		
370	229-235 368,371 374,378 381,382	8/24/2005	РТ		
370	383,395.7	8/24/2005	РТ		
370	395.71	8/24/2005	PT		
370	395.72	8/24/2005	PT		
370	412-429	8/24/2005	PT		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East	8/23/2005	РТ		